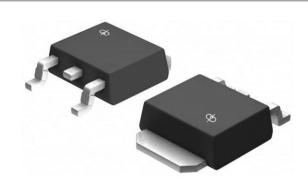


40A, 150V N-CHANNEL ENHANCED MODE POWER MOSFET

DESCRIPTION:



The ALP40N15S is an 40A, 150V N-Channel Enhanced Mode Power MOSFET and it has high density cell design for ultra low $R_{DS(on)}$

FEATURES:

- $V_{(BR)DSS} = 150V$, $I_D = 40A$
- $R_{DS(ON)MAX} = 45 m\Omega$ @ $V_{GS} = 10V$, $I_D = 40A$.
- High density cell design for ultra-low R_{DS(on)}.
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high EAS
- Excellent package for good heat dissipation
- Suffix "-H" indicated Halogen Free part, ex. ALP40N15S-H

APPLICATIONS:

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply.

MECHANICAL CHARACTERISTICS

Case: Molded plastic, TO-252AB

Mounting Position: Any.



MAXIMUM RATINGS

MAXIMUM RATINGS @ T _A = 25 °C unless otherwise specified						
PARAMETER SYMBOL RATINGS UNIT						
Drain-Source Voltage	V_{DS}	150	V			
Gate-Source Voltage	V_{GS}	±20	V			
Continuous Drain Current	I _D	40	А			
Pulsed Drain Current	I _{DM}	160	А			
Power Dissipation	P_{D}	140	W			
Thermal Resistance Junction to Case	$R_{ heta$ JC	1.07	°C/W			
Single pulse avalanche energy	E _{AS}	310	mJ			
Operating Junction Temperature	Tı	+150	°C			
Storage Temperature Range	T _{STG}	-55 to +150	°C			



beyond boundaries...

ELECTRICAL CHARACTERISTICS @ TA = 25 °C unless otherwise specified

PARAMETER	CONDITIONS	SYMBOL	MIN	TYP.	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250 μA	V _{(BR)DSS}	150			V
Zero gate voltage drain current	V _{DS} =150V, V _{GS} =0V	I _{DSS}			1.0	μΑ
Gate-body leakage current	V _{GS} = ±20V, V _{DS} = 0V	I _{GSS}			±100	nA
ON CHARACTERISTICS						
Gate-Threshold Voltage	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	$V_{GS(th)}$	2.5		4.5	V
Drain-to-Source On-Resistance (Note 1)	V _{GS} = 10V, I _D = 18A	R _{DS(ON)}		35	45	mΩ
Forward transconductance (Note 1)	V _{DS} =15V, I _D =18A	G FS	38			S

DYNAMIC CHARACTERISTICS (Note 2)						
PARAMETER	CONDITIONS	SYMBOL	MIN	TYP.	MAX	UNIT
Input Capacitance	$V_{DS} = 25V$, $V_{GS} = 0V$, $F_{req} = 1.0$ MHz	C _{iss}		4200		pF
Output Capacitance	$V_{DS} = 25V$, $V_{GS} = 0V$, $F_{req} = 1.0$ MHz	Coss		203		pF
Reserve Transfer Capacitance	$V_{DS} = 25V$, $V_{GS} = 0V$, $F_{req} = 1.0$ MHz	C_{rss}		96		pF

SWITCHING CHARACTERISTICS						
PARAMETER	CONDITIONS SYMBOL MIN		TYP.	MAX	UNIT	
Total Gate Charge	$V_{DS} = 30V$, $V_{GS} = 10V$, $I_D = 30A$	Qg		105		nC
Gate to Source Charge	$V_{DS} = 30V, V_{GS} = 10V, I_D = 30A$	Q_{gs}		21		nC
Gate to Drain Charge	$V_{DS} = 30V$, $V_{GS} = 10V$, $I_D = 30A$	Q_{gd}		31.5		nC
Turn-On Delay Time	$V_{DD} = 30V, V_{GS} = 10V, I_D = 2A,$ $R_L = 15\Omega, R_{GEN} = 2.5\Omega$	t _{d(on)}		17.8		nS
Turn-On Rise time	$V_{DD} = 30V, V_{GS} = 10V, I_D = 2A,$ $R_L = 15\Omega, R_{GEN} = 2.5\Omega$	tr		11.8		nS
Turn-Off Delay Time	$V_{DD} = 30V, V_{GS} = 10V, I_D = 2A,$ $R_L = 15\Omega, R_{GEN} = 2.5\Omega$	t _{d(off)}		56		nS
Turn-Off Fall time	$V_{DD} = 30V, V_{GS} = 10V, I_D = 2A,$ $R_L = 15\Omega, R_{GEN} = 2.5\Omega$	t _f		14.6		nS

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS						
PARAMETER CONDITIONS			MIN	TYP.	MAX	UNIT
Diode forward Current (Note 1)		Is			40	Α
Diode forward Voltage	$I_S = 18A$, $V_{GS} = 0V$	V_{DS}			1.2	V
Reverse recovery time	$T_J = 25$ °C, $I_F = 18A$, $di/dt = 100A/\mu s$ (Note 1)	t _{rr}		70		nS
Reverse recovery charge	$T_J = 25$ °C, $I_F = 18A$, di/dt =100A/ μ s (Note 1)	Q _{rr}		230		nC

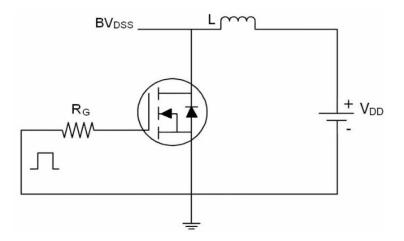
Note:

- 1. Pulse test (pulse width \leq 300 μ s, Duty cycle \leq 2%.
- 2. Guaranteed by design, not subject to production testing.

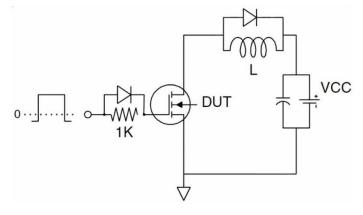


TEST CIRCUIT

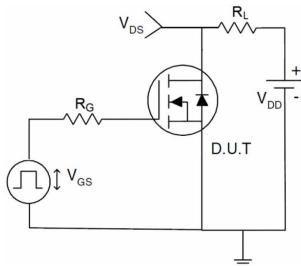
1) EAS TEST CIRCUIT



2) GATE CHARGE TEST CIRCUIT



3) SWITCH TIME TEST CIRCUIT





TYPICAL DEVICE RATING AND CHARACTERISTICS CURVES (T_A = 25 °C unless otherwise noted)

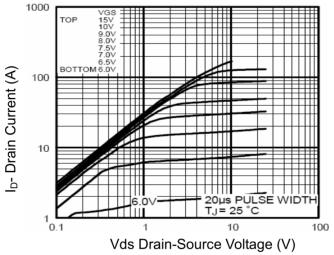


Fig.1 OUTPUT CHARACTERISTICS

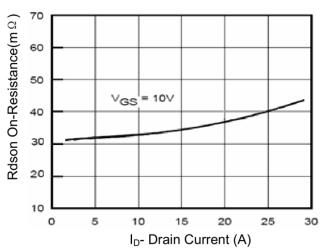
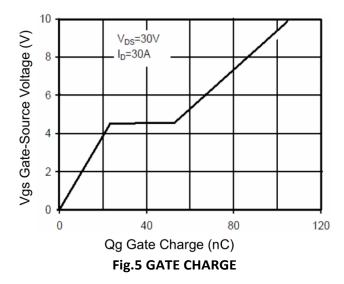


Fig.3 R_{DS(on)} – DRAIN CURRENT



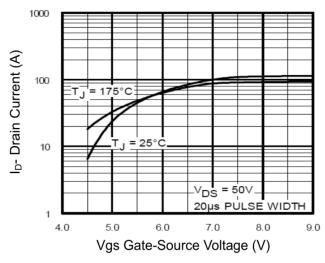


Fig.2 TRANSFER CHARACTERISTICS

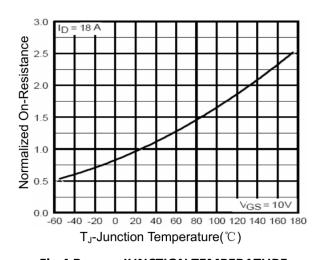


Fig.4 R_{DS(on)} – JUNCTION TEMPERATURE

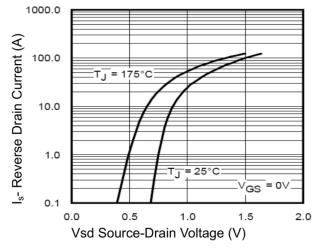


Fig. 6 SOURCE - DRIAN DIODE FORWARD



beyond boundaries...

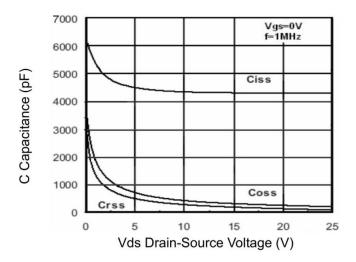


Fig.7 CAPACITANCE vs V_{DS}

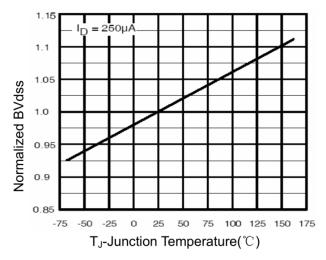
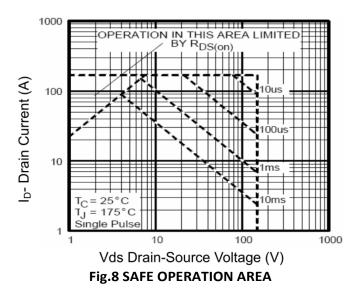


Fig.9 BV_{DSS} vs JUNCTION TEMPERATURE



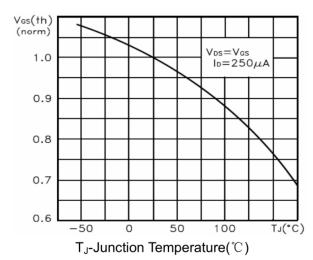
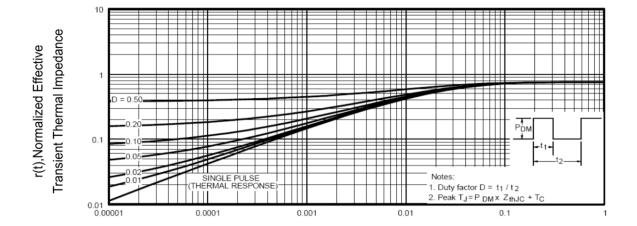


Fig. 10 V_{GS(th)} vs JUNCTION TEMPERATURE



Square Wave Pluse Duration(sec)

Fig.11 NORMALIZED MAXIMUM TRANSIENT THERMAL IMPEDANCE



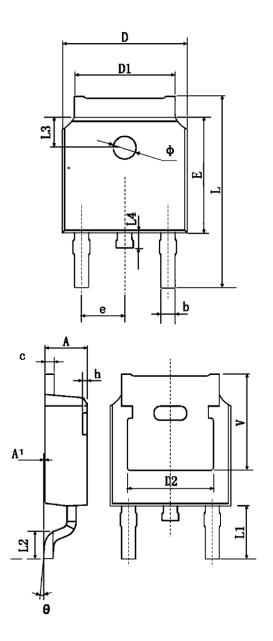
PINNING INFORMATION

PIN	SIMPLIFIED OUTLINE	CIRCUIT DIAGRAM
S Source G Gate D Drain		G



PACKAGE INFORMATION

TO-252AB



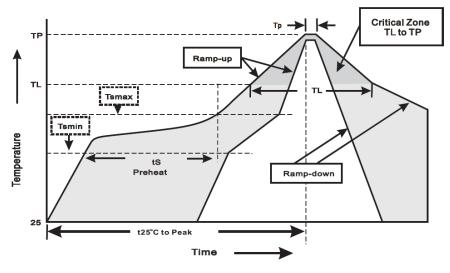
OUTLINE DIMENSIONS					
	MILLIMETERS		INCH	IES	
SYMBOL	MIN	MAX	MIN	MAX	
Α	2.200	2.400	0.087	0.094	
A1	0.000	0.127	0.000	0.005	
b	0.660	0.860	0.026	0.034	
С	0.460	0.580	0.018	0.023	
D	6.500	6.700	0.256	0.264	
D1	5.100	5.460	0.201	0.215	
D2	4.83	0 TYP.	0.190	TYP.	
E	6.000	6.200	0.236	0.244	
е	2.186	2.386	0.086	0.094	
L	9.800	10.400	0.386	0.409	
L1	2.90	0 TYP.	0.114	TYP.	
L2	1.400	1.700	0.055	0.067	
L3	1.60	0 TYP.	0.063	TYP.	
L4	0.600	1.000	0.024	0.039	
φ	1.100	1.300	0.043	0.051	
θ	0°	8°	0°	8°	
h	0.000	0.300	0.000	0.012	
V	5.350 TYP.		0.211	TYP.	



SOLDERING PARAMETERS

SUGGESTED THERMAL PROFILES FOR SOLDERING PROCESSES

- 1. Storage environment: Temperature=5 °C~40 °C Humidity=55% ±25%
- 2. Reflow soldering of surface-mount devices



3. Reflow soldering

PROFILE FEATURE	SOLDERING CONDITION
Average ramp-up rate (T _L to T _P)	<3 °C/sec
Preheat	
- Temperature Min (T _{smin})	150 °C
- Temperature Max (T _{smax})	200 °C
- Time (min to max) (t _s)	60 ~ 120 sec
T _{smax} to T _L	
- Ramp-upRate	<3 °C/sec
Time maintained above:	
- Temperature (T _L)	217 °C
- Time(tL)	60 ~ 260 sec
Peak Temperature (T _P)	255 °C-0/+5 °C
Time within 5 °C of actual Peak	10 ~ 30 sec
Temperature(tP)	
Ramp-down Rate	<6 °C/sec
Time 25 °C to Peak Temperature	<6 minutes



CUSTOMER NOTE:

DISCLAIMER

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- 2. In Europe, please dispose as per EU Directive 2002/96/EC on Waste Electrical and Electronic Equipment (WEEE).



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